

Search Notes

Application/Control No.

10/607,281

Examiner

Con P. Tran

Applicant(s)/Patent under
Reexamination

BECK ET AL.

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner
381	313, 315	12/29/2006	CPT
	1, 23.1	7/26/2007	
	312, 358,	8/3/2007	
	60		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC/PLUS	9/8/2006	CPT
Brian Pendleton	1/5/2007	CPT
Vivian Chin	8/2/2007	CPT
Suhan Ni	8/2/2007	CPT
EAST (US-PGPUB, USPT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	8/9/2007	CPT